Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!

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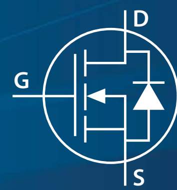
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

EPC2037 – Enhancement Mode Power Transistor

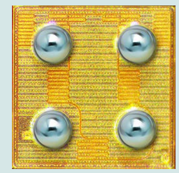
V_{DSS} , 100 V
$R_{DS(on)}$, 550 mΩ
I_D , 1.7 A



EFFICIENT POWER CONVERSION

RoHS Halogen-Free

Gallium Nitride is grown on Silicon Wafers and processed using standard CMOS equipment leveraging the infrastructure that has been developed over the last 60 years. GaN's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR}. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.



EPC2037 eGaN® FETs are supplied only in passivated die form with solder bumps.
Die size: 0.9 mm x 0.9 mm

Applications
- High Speed DC-DC Conversion
- Wireless Power Transfer
- LiDAR/Pulsed Power Applications
- Class-D Audio

Benefits
- Ultra High Efficiency
- Ultra Low $R_{DS(on)}$
- Ultra Low Q_G
- Ultra Small Footprint

www.epc-co.com/epc/Products/eGaNFETs/EPC2037.aspx

Maximum Ratings			
V_{DS}	Drain-to-Source Voltage (Continuous)	100	V
	Drain-to-Source Voltage (up to 10,000 5ms pulses at 150˚C)	120	
I_D	Continuous (T_A = 25˚C, $R_{θJA}$= 44˚C/W)	1.7	A
	Pulsed (25˚C, T_{PULSE} = 300 µs)	2.4	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-4	
T_J	Operating Temperature	-40 to 150	˚C
T_{STG}	Storage Temperature	-40 to 150	

Static Characteristics (T_J= 25˚C unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-to-Source Voltage	V_{GS} = 0 V, I_D = 125 µA	100			V
I_{DSS}	Drain Source Leakage	V_{DS} = 80 V, V_{GS} = 0 V		10	100	µA
I_{GSS}	Gate-to-Source Forward Leakage	V_{GS} = 5 V		0.1	1	mA
	Gate-to-Source Reverse Leakage	V_{GS} = -4 V		10	100	µA
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 0.8 mA	0.8	1.5	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	V_{GS} = 5 V, I_D = 0.1 A		400	550	mΩ
V_{SD}	Source-Drain Forward Voltage	I_S = 0.3 A, V_{GS} = 0 V		2.5		V

All measurements were done with substrate shorted to source.

Thermal Characteristics			
		TYP	UNIT
$R_{θJC}$	Thermal Resistance, Junction to Case	14	˚C/W
$R_{θJB}$	Thermal Resistance, Junction to Board	79	˚C/W
$R_{θJA}$	Thermal Resistance, Junction to Ambient (Note 1)	100	˚C/W

Note 1: $R_{θJA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board.
See http://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

Dynamic Characteristics (T_J = 25˚C unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{ISS}	Input Capacitance	V_{DS} = 50 V, V_{GS} = 0 V		14	17	pF
C_{RSS}	Reverse Transfer Capacitance			0.1		
C_{OSS}	Output Capacitance			6.5	10	
$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	V_{DS} = 0 to 50 V, V_{GS} = 0 V		9.5		
$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			12		
R_G	Gate Resistance			0.5		Ω
Q_G	Total Gate Charge	V_{DS} = 50 V, V_{GS} = 5 V, I_D = 0.1 A		115	145	pC
Q_{GS}	Gate to Source Charge	V_{DS} = 50 V, I_D = 0.1 A		32		
Q_{GD}	Gate to Drain Charge			25		
$Q_{G(TH)}$	Gate Charge at Threshold			24		
Q_{OSS}	Output Charge	V_{DS} = 50 V, V_{GS} = 0 V		600	900	
Q_{RR}	Source-Drain Recovery Charge			0		

Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.
Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1: Typical Output Characteristics at 25°C

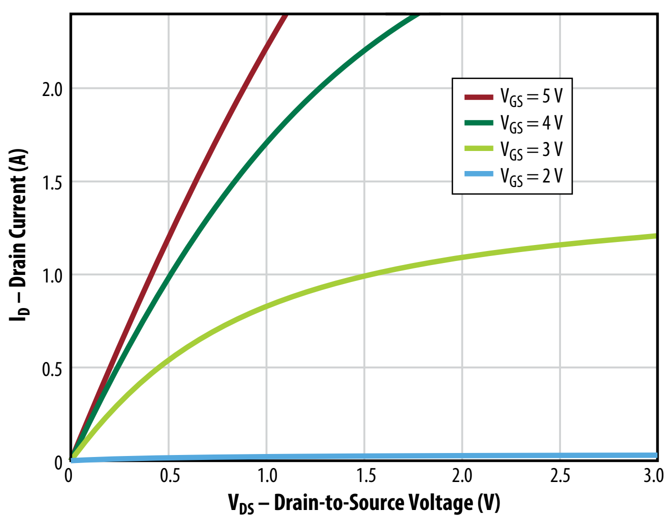


Figure 2: Transfer Characteristics

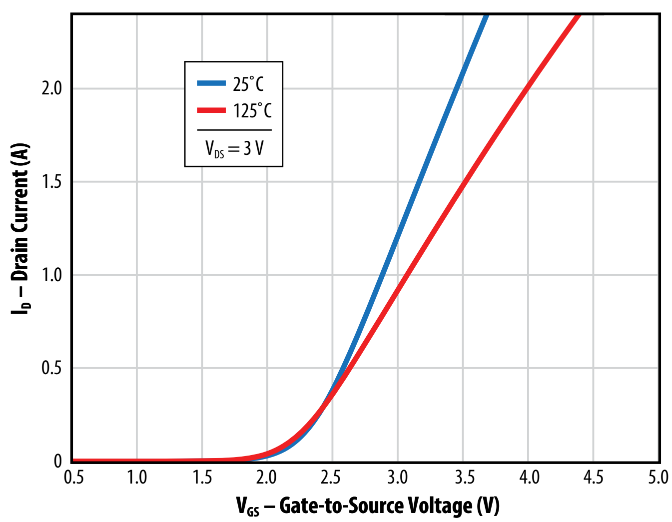


Figure 3: $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

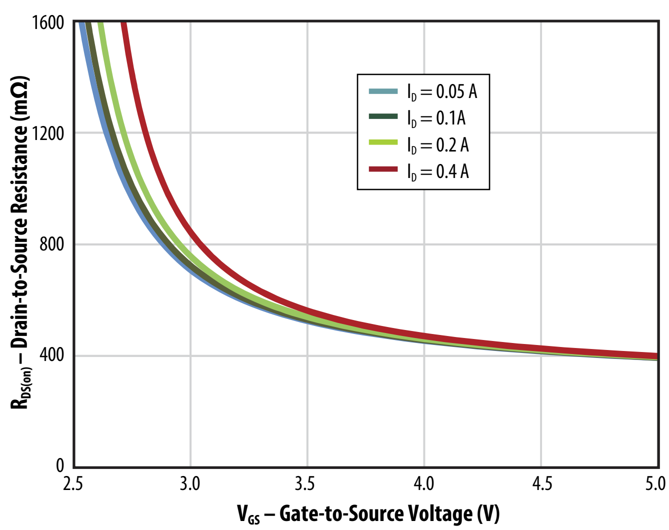


Figure 4: $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

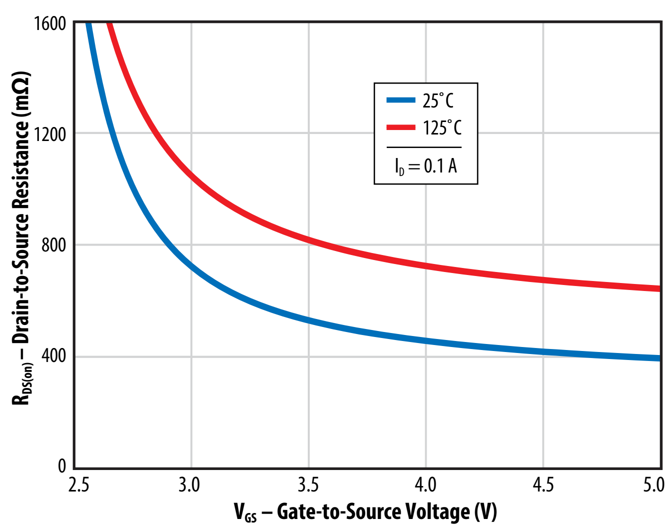


Figure 5a: Capacitance (Linear Scale)

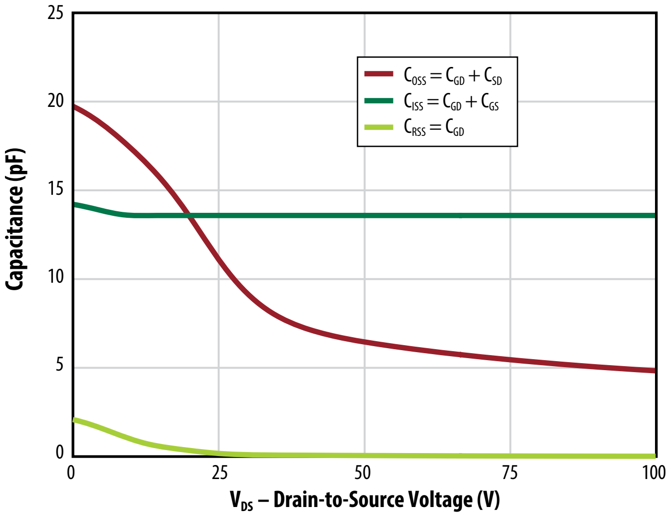


Figure 5b: Capacitance (Log Scale)

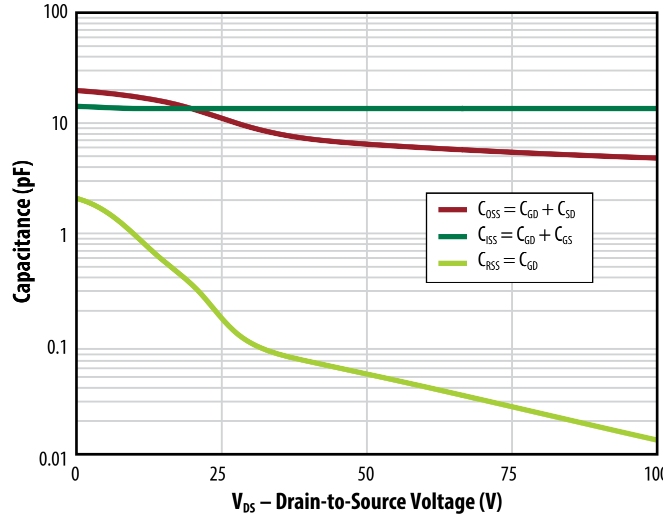


Figure 6: Gate Charge

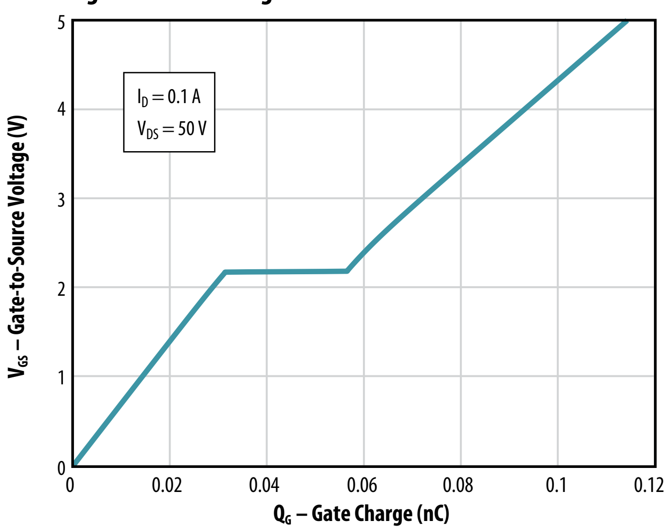


Figure 7: Reverse Drain-Source Characteristics

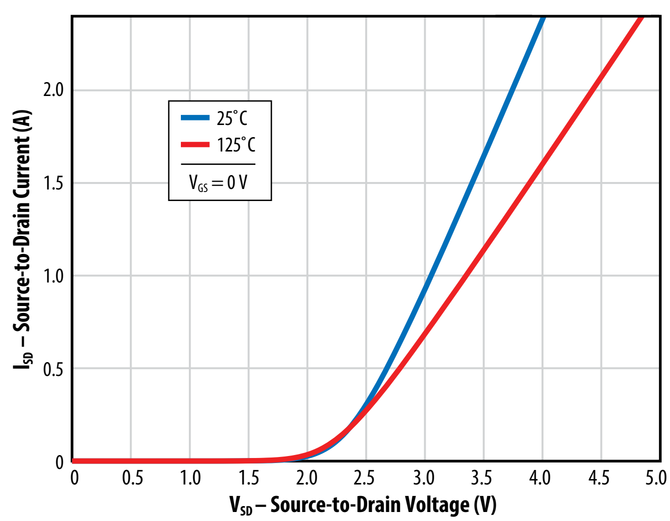


Figure 8: Normalized On-State Resistance vs. Temperature

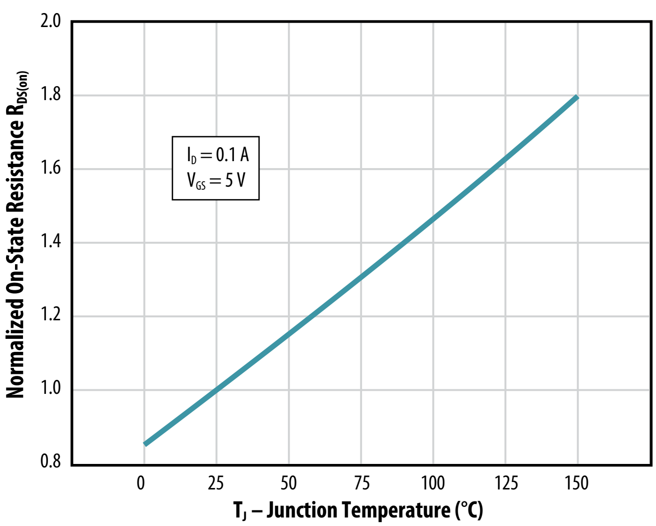


Figure 9: Normalized Threshold Voltage vs. Temperature

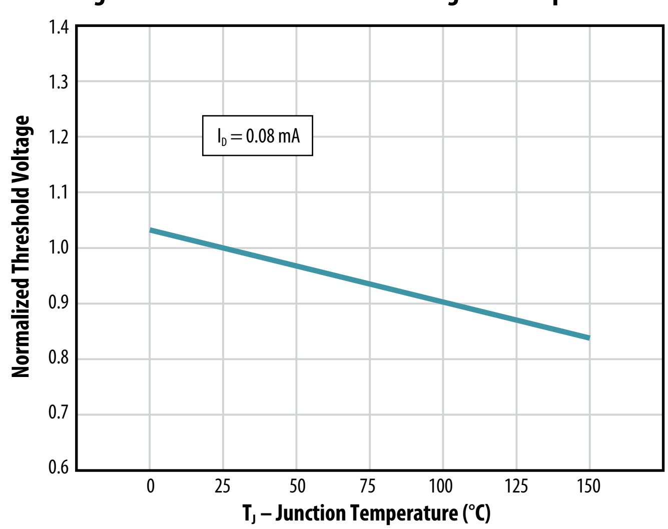


Figure 10: Safe Operating Area

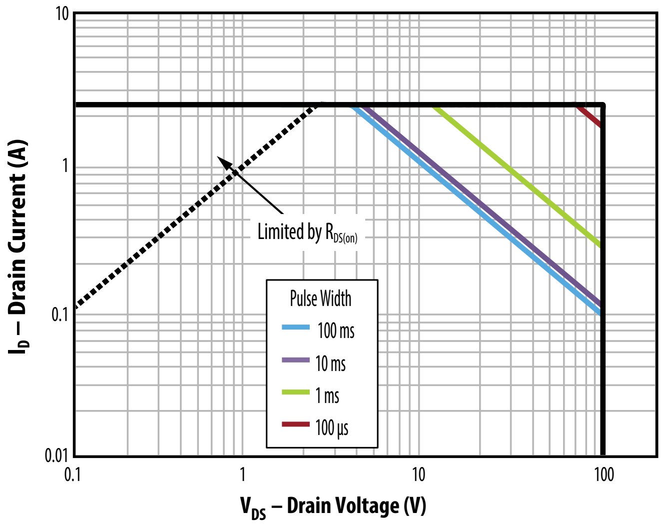
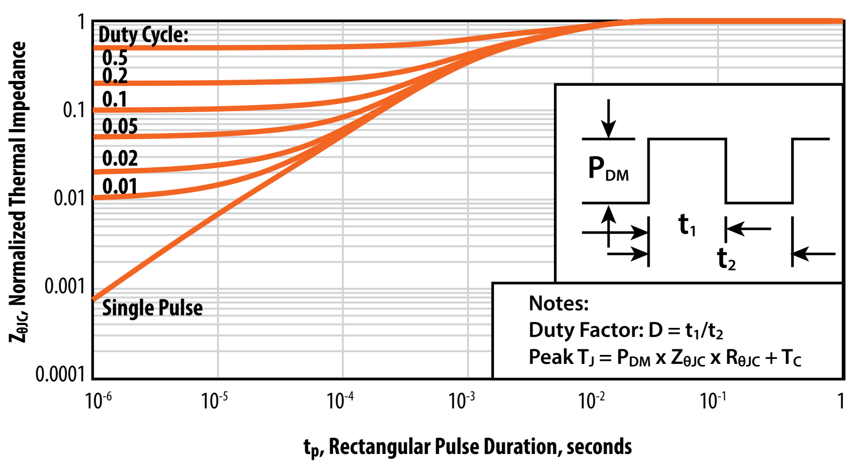
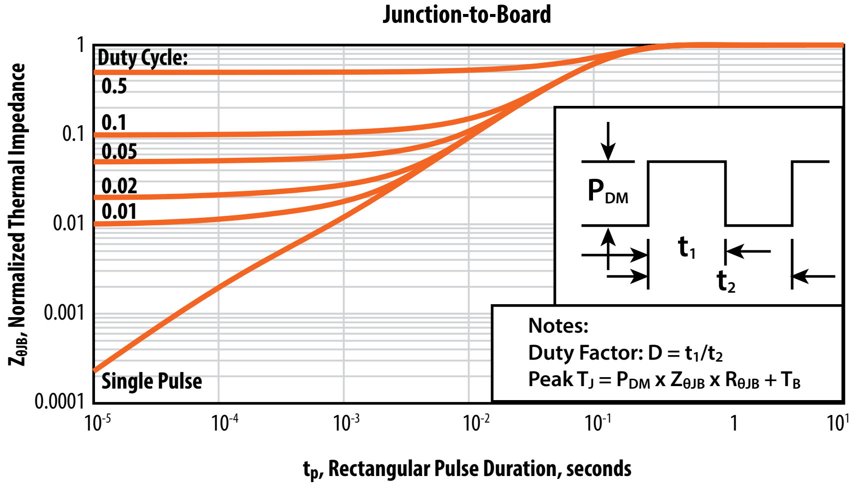


Figure 11: Transient Thermal Response Curves

Junction-to-Case

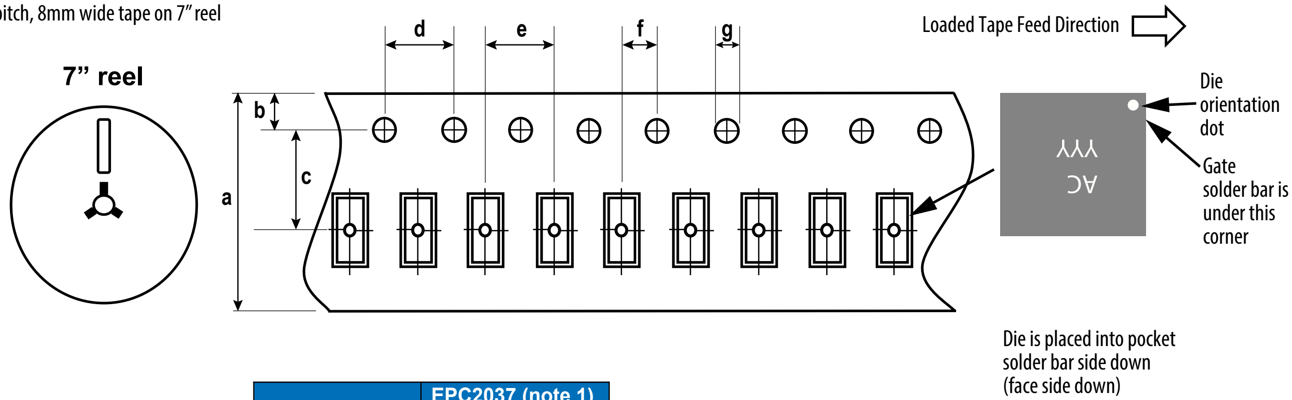


Junction-to-Board



TAPE AND REEL CONFIGURATION

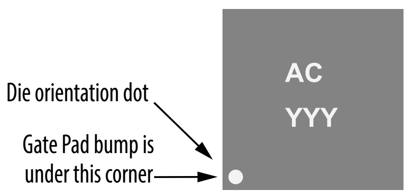
4mm pitch, 8mm wide tape on 7" reel



	EPC2037 (note 1)		
Dimension (mm)	target	min	max
a	8.00	7.90	8.30
b	1.75	1.65	1.85
c (see note)	3.50	3.45	3.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (see note)	2.00	1.95	2.05
g	1.5	1.5	1.6

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.
Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

DIE MARKINGS

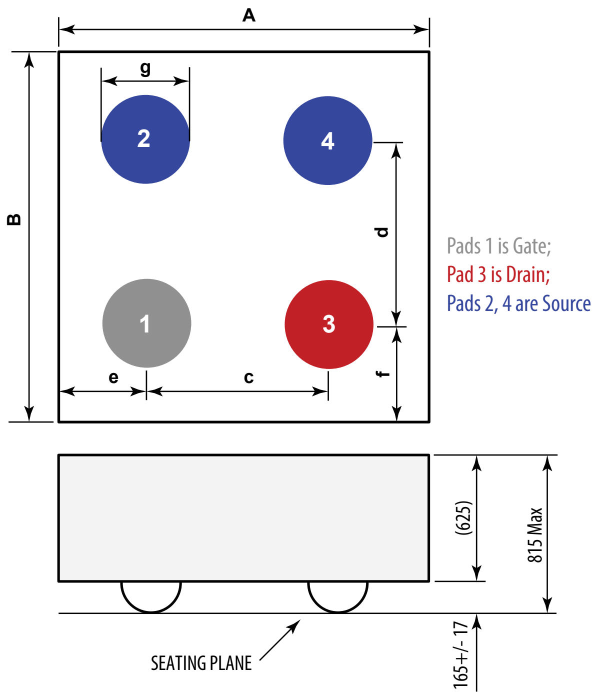


Part Number	Laser Markings	
	Part # Marking Line 1	Lot_Date Code Marking line 2
EPC2037	AC	YYY

DIE OUTLINE

Solder Bump View

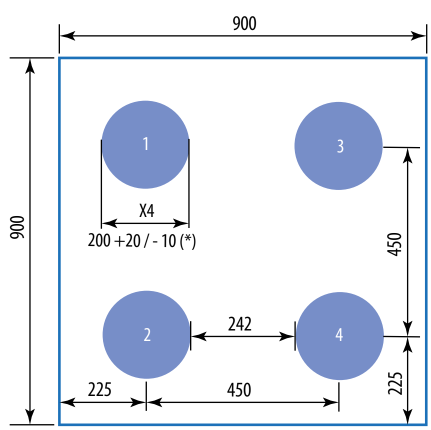
Side View



DIM	MIN	Nominal	MAX
A	870	900	930
B	870	900	930
c	450	450	450
d	450	450	450
e	210	225	240
f	210	225	240
g	187	208	229

RECOMMENDED LAND PATTERN

(measurements in µm)



* minimum 190

The land pattern is solder mask defined

Solder mask is 10 µm smaller per side than bump

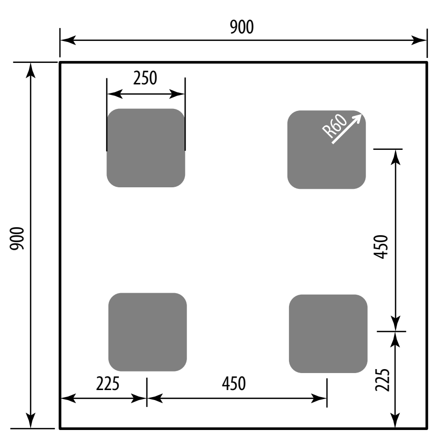
Pads 1 is Gate;

Pad 3 is Drain;

Pads 2, 4 are Source

RECOMMENDED STENCIL DRAWING

(measurements in µm)



Recommended stencil should be 4mil (100 µm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at http://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx